

**Search Notes**

Application/Control No.

10/510,241

Examiner

Tan Le

Applicant(s)/Patent under  
Reexamination

JANG, YOU-SEOK

Art Unit

3632

**SEARCHED**

Class	Subclass	Date	Examiner
248	118, 118.1	10/16/2006	TL
	118.3		
	118.5		
	917-		
	924		
361	681-682		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See	Attachment	10/16/2006	TL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated text searche.	10/16/2006	TL